

LOW ENERGY ELECTRON COLLISIONS IN SiF_4

R. Nagpal, A. Garscadden, D. Liptak[†], and J. D. Clark[†]

Wright Laboratory, WPAFB, OH-45433, USA

[†]Physics Department, Wright State University, OH-45435, USA

ABSTRACT

Electron drift velocities in $\text{SiF}_4\text{-Ar}$ mixtures have been measured using a pulsed-Townsend type drift tube. A set of momentum transfer, vibrational excitation, dissociation, attachment, and ionization cross sections of electron scattering in SiF_4 from 0 – 50 eV is presented. The cross section set has been determined by the swarm analyses of electron transport data in pure SiF_4 , in conjunction with the data in $\text{SiF}_4\text{-Ar}$ mixtures.

INTRODUCTION

Electron collisional processes and transport in Group IV tetrafluorides (CF_4 , SiF_4) are of considerable interest due to their wide applications in dry etching for the fabrication of microelectronic devices. The ν_3 fundamental vibrational mode of SiF_4 is of special interest in the field of laser spectroscopy due to the possibility of achieving measurements with sub-Doppler resolution on single transitions coinciding with CO_2 laser lines [1]. SiF_4 is also of interest in laser photochemistry [2], and has been the subject of investigation in IR spectroscopy [3].

While there exists considerable information on the low energy electron collision cross sections in CF_4 [4, 5] in the literature, the corresponding data for SiF_4 , especially the momentum transfer and vibrational excitation cross sections are not known. Absolute cross sections for the electron impact dissociation of SiF_4 (> 10 eV) into neutral radicals, ionization [6] and electron attachment [7] have been measured. Electron energy loss spectra for the energy loss range of 10-30 eV [8], and photoabsorption studies in SiF_4 in the high energy region (>10 eV) have also been reported [9, 10]. On the swarm frontier, electron transport data comprising of drift velocities (w_d), attachment (η/N), and ionization (α/N) coefficients in SiF_4 have recently been measured [11]. In this paper, we report a set of low energy electron collision cross sections in SiF_4 derived from the swarm analyses of the electron transport data of [11]. The cross section set includes momentum transfer (q_m), vibrational excitation, and is extended towards high energies using the measurements of [6, 7]. For checks on the consistency of the

derived cross section data, measurements and analyses of electron drift velocities in SiF_4 -Ar mixtures are also reported.

EXPERIMENT AND ANALYSIS

The experimental apparatus is a classical pulsed-Townsend type drift tube described in detail in [12]. A photoelectron swarm is initiated by the laser irradiation of a gold-palladium photocathode using a 266 nm quadrupled Nd Yag laser. The laser initiated swarm (6ns) drifts under the influence of the uniform electric field through a drift distance of 6.455 cm. The charge swarm is collected at the anode with a current integrating amplifier. The averaged charge ramp (over 128 repetitions of the swarm) is analyzed for the time of maximum charge arrival and this time is designated as the arrival time of the swarm. The w_d is determined from the ratio of the drift distance to the arrival time and is not corrected for the effects of diffusion, ionization or attachment.

The w_d measurements were made in gas mixtures from 0.1% to 4.8% SiF_4 in Ar. The gas mixtures were made by volume mixing in the drift tube using a pre-prepared mixture of 4.8% SiF_4 in Ar with pure Ar (both Matheson Semiconductor Grade). The mixing ratios were determined by pressure measurements using 10 Torr and 1000 Torr capacitive manometers. The w_d measurements have an accuracy of 2% based on the measurement uncertainties of the pressure, voltage, temperature, mixture ratio, and arrival time.

The electron kinetics in the swarm analyses was obtained by conventional “two-term” solution of the collisional Boltzmann transport equation (BTE) [13]. A set of *trial* cross sections was constructed as the input to the numerical solution of the BTE. The *trial* cross section set was constructed with the inelastic threshold information (table 1), and a judicious estimate (based on comparisons with CF_4) of the magnitude, and the shape of the cross sections, near and above their thresholds.

Process	Threshold (eV)	Label
Vibration ν_1	0.099	$\sigma_{\nu 1}$
Vibration ν_2	0.032	$\sigma_{\nu 2}$
Vibration ν_3	0.126	$\sigma_{\nu 3}$
Vibration ν_4	0.052	$\sigma_{\nu 4}$
$e + SiF_4 \rightarrow SiF_3 + F + e$	10.8	σ_{d1}
$e + SiF_4 \rightarrow SiF_2 + F_2 + e$	13.9	σ_{d2}
$e + SiF_4 \rightarrow SiF_3^- + F$	10.1	σ_a
$e + SiF_4 \rightarrow SiF_3^+ + F + 2e$	16.0	σ_i

Table 1: Inelastic processes and their thresholds considered for SiF_4

The w_d were then calculated from the following expression.

$$w_d = -\frac{1}{3} \left(\frac{2e}{m_e} \right)^{1/2} \left(\frac{E}{N} \right) \int_0^\infty \frac{1}{\sum_s \delta_s \sigma_T^s(\epsilon)} \frac{df_0(\epsilon)}{d\epsilon} \epsilon d\epsilon \quad (1)$$

where e is the electronic charge, m_e is the electronic mass, δ_s is the fractional concentration of species s in the gas mixture, σ_T^s is the total scattering cross section of species s , ϵ is the electron energy, and f_0 is the isotropic component of the electron energy distribution function (EEDF). The calculated w_d were then compared with the experimental data. If the difference between the experimental and calculated w_d was greater than the experimental error margins, then the cross sections were modified in the appropriate energy range. The comparison and modification of the cross sections were repeated till a satisfactory agreement between the calculated and the experimental data was achieved. The collision cross sections of Ar were taken from [14], and were fixed throughout this study.

RESULTS AND DISCUSSION

Figure 1 presents the comparisons between the experimental and the calculated w_d in Ar , pure SiF_4 , and % SiF_4 - Ar mixtures from the converged cross set of SiF_4 in the unfolding procedure. Since the elastic scattering in the highly dilute mixture is essentially controlled by Ar , the initial estimates of the vibrational excitation cross sections of SiF_4 were made from the w_d data of 0.1% mixture. From beyond 1% mixture composition, the q_m of SiF_4 also have to be included in the swarm analyses. The w_d data in gas mixtures are dominated by the well known phenomenon of Negative Differential Conductivity [15]. This feature also shows up at higher E/N in pure SiF_4 . Further, at low E/N , the w_d data in mixtures show a large increase over corresponding data of either constituent gas (figure 1). The demanding requirement to achieve agreement with the experimental w_d - E/N -concentration *surface* enhances uniqueness in the derived cross sections.

Once the low energy momentum transfer and vibrational excitation cross sections were determined, the data base was extended towards higher electron energies to include attachment, dissociation and ionization. It is to be noted that since the errors in the swarm analysis are correlated at different energies, the accuracy in the swarm analysis towards high electron energies is very sensitive to the magnitude of the electron scattering at low energies. Figure 2 presents the comparisons between the experimental and the calculated η/N , α/N coefficients [11]. These coefficients were calculated by the following expression.

$$\frac{\eta}{N} = \frac{k_a}{w_d} \quad \text{and} \quad \frac{\alpha}{N} = \frac{k_i}{w_d} \quad (2)$$

where k_a and k_i are the rate coefficients for electron impact attachment and ionization processes respectively. The converged cross section set of SiF_4 is shown in figure 3. We note that whereas minor adjustments to the measured attachment cross sections [7] were required to fit the η/N data, the measured cross sections for dissociation and ionization [6] required significant modifications in the α/N calculations. The reason for this is that the calculations of k_i are very sensitive to the magnitudes of σ_{d1} and σ_{d2} . Further, since the errors in the absolute cross sections of [7] may be as high as 100%, the agreement between the the measurements of [7] and figure 3 is considered fair.

Finally, we would like to add a comment of caution for the cross sections presented in figure 3. Since these cross sections have been essentially derived from “two-term” calculations of the Boltzmann equation, they will always be consistent as long as the electron kinetics are obtained from the “two-term” approximation. The large magnitudes of σ_ν as compared to those of σ_m indicate that in the proximity of the electron energies where vibrational excitation is the dominant inelastic process, the “two-term” approximation is no longer valid for the description of electron collisional kinetics [16] (the EEDF is highly anisotropic). The discrepancies between the “two-term” and the “multi-term” or “Monte-Carlo” calculated transport coefficients can be quite large at the E/N values where vibrational excitation dominates [16, 13]. A “Monte-Carlo” analysis of the electron transport and subsequent improvements to the cross sections (particularly to σ_m) are currently in progress.

ACKNOWLEDGEMENT

This work has been funded in part by Sandia National Laboratories under a CRADA with SEMATECH.

References

- [1] L. Jörissen, H. Prinz, W. A. Kreiner, C. Wenger, G. Pierre, G. Magerl, and W. Schupita, *Can. J. Phys.* **67**, 532 (1989).
- [2] J. L. Lymon and S. D. Rockwood, *J. Appl. Phys.* **47**, 595 (1976).
- [3] E. A. Jones, J. S. Kirby-Smith, P. J. H. Woltz, and A. H. Nielsen, *J. Chem. Phys.* **19**, 242 (1951).
- [4] W. L. Morgan, *Plasma Chem. Plasma Proc.* **12**, 477 (1992).
- [5] B. Stefanov and P. Pirgov, *Plasma Chem. Plasma Proc.* **13**, 655 (1993).
- [6] T. Nakano and H. Sugai, *J. Phys. D: Appl. Phys.* **26**, 1909 (1993).
- [7] I. Iga, M. V. V. S. Rao, S. K. Srivastava, and J. C. Nogueira, *Z. Phys. D* **24**, 111 (1992).
- [8] K. Kuroki, D. Spence, and M. A. Dillon, *J. Elec. Spec.* **70**, 151 (1994).
- [9] M. Suto, X. Wang, L. C. Lee, and T. J. Chuang, *J. Chem. Phys.* **86**, 1152 (1987).
- [10] K. Kameta, M. Ukai, T. Numazawa, N. Terazawa, Y. Chikahiro, N. Kouchi, Y. Hatano, and K. Tanaka, *J. Chem. Phys.* **99**, 2487 (1993).
- [11] S. R. Hunter, J. G. Carter, and L. G. Christophorou, *J. Appl. Phys.* **65**, 1858 (1989).

- [12] D. J. Mosteller, M. L. Andrews, J. D. Clark, and A. Garscadden, J. Appl. Phys. **74**, 2247 (1993).
- [13] A. V. Phelps and L. C. Pitchford, Phys. Rev. A **31**, 2932 (1985).
- [14] Y. Nakamura and M. Kurachi, J. Phys. D: Appl. Phys. **21**, 178 (1988).
- [15] W. H. Long, W. F. Bailey, and A. Garscadden, Phys. Rev. A **13**, 471 (1976).
- [16] R. Nagpal and A. Garscadden, J. Appl. Phys. **75**, 703 (1994).

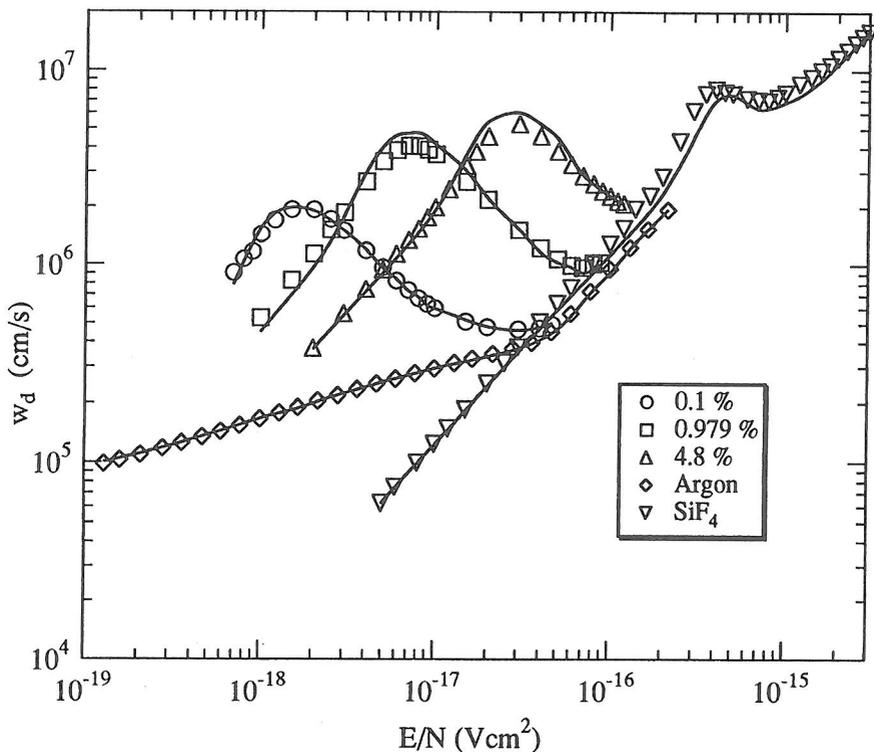


Figure 1: Electron drift velocities in Ar , SiF_4 , and $SiF_4 - Ar$ mixtures. Points represent experimental data. Lines represent calculations using the converged cross sections derived from the swarm analyses.

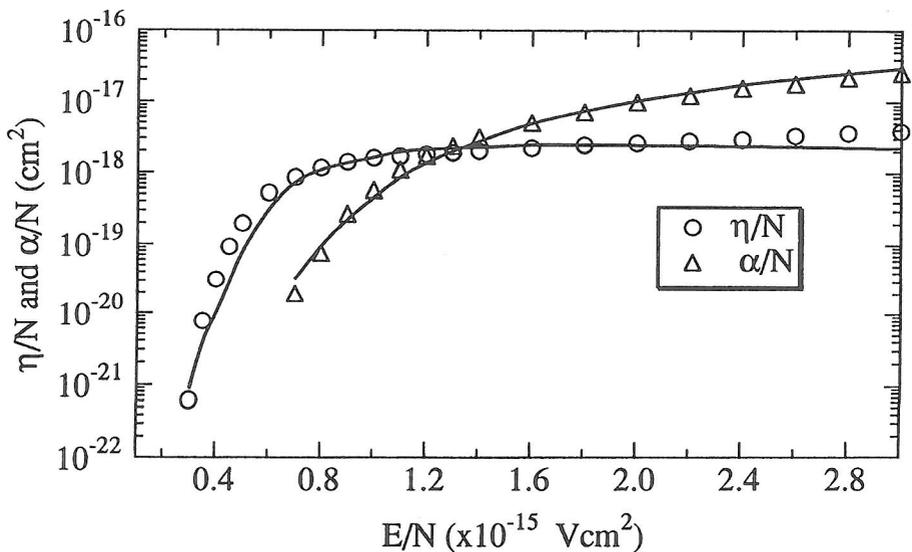


Figure 2: Electron attachment and ionization coefficients in SiF_4 . Points represent experimental data [11]. Lines represent calculations using the converged cross sections derived from the swarm analyses.

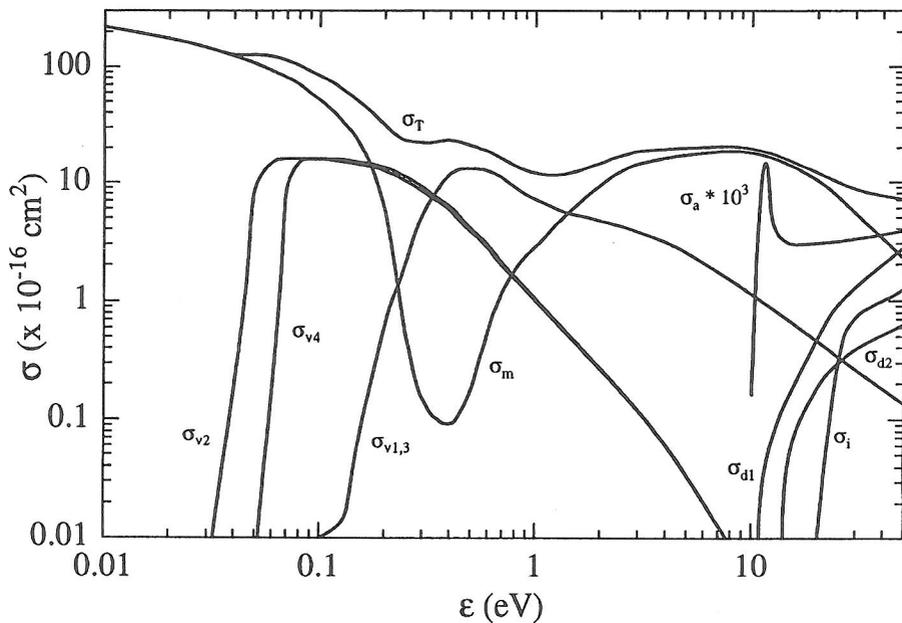


Figure 3: Swarm derived electron collision cross section set of SiF_4 . Refer to table 1 for denoted symbols.